

# MP38900/MP38900-B

High Efficiency, Fast Transient, 10A, 16V Synchronous Step-down Converter In a Tiny QFN20 (3x4mm) Package

**END OF LIFE** 

#### DESCRIPTION

The MP38900/MP38900-B is a fully integrated, high frequency synchronous rectified step-down switch mode converter. It offers a very compact solution to achieve 10A continuous output current over a wide input supply range with excellent load and line regulation. The MP38900/MP38900-B operates at high efficiency over a wide output current load range.

The table below summarizes the variations among the MP38900 and the MP38900-B.

MP38900	External Vcc	OCP Latch Off	Soft SHDN
MP38900-B	Built-in Vcc	OCP Hiccup	Hi-Z SHDN

To futher optimize efficiency at light load, the  $V_{\text{CC}}$  supply of MP38900 is designed to be biased externally.

Constant-On-Time (COT) control mode provides fast transient response and eases loop stabilization.

Full protection features include SCP, OCP, OVP, UVP and thermal shutdown.

The MP38900/MP38900-B requires a minimum number of readily available standard external components and is available in a space-saving QFN20 (3x4mm) package.

## **FEATURES**

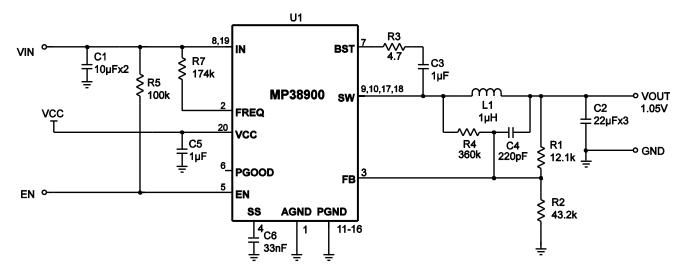
- Wide 4.5V to 16V Operating Input Range
- 10A Output Current
- Internal  $27m\Omega$  High-Side,  $10m\Omega$  Low-Side Power MOSFETs
- Proprietary Switching Loss Reduction Technique
- 1% Reference Voltage
- Programmable Soft Start Time
- Soft Shutdown (MP38900,)
- High-Z Shutdown (MP38900-B)
- Programmable Switching Frequency
- SCP, OCP, OVP, UVP Protection and Thermal Shutdown
- Output Adjustable from 0.8V to 13V
- Available in a QFN20 (3x4mm) Package

## **APPLICATIONS**

- Notebook Systems and I/O Power
- Networking Systems
- Optical Communication Systems
- Distributed Power POL Systems

All MPS parts are lead-free and adhere to the RoHS directive. For MPS green status, please visit MPS website under Quality Assurance. "MPS" and "The Future of Analog IC Technology" are Registered Trademarks of Monolithic Power Systems, Inc.

# **TYPICAL APPLICATION**



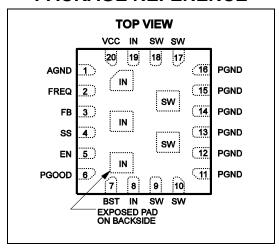
## ORDERING INFORMATION

Part Number	Package	Top Marking
MP38900DL*	QFN20 (3x4mm)	38900
MP38900DL-B***	QFN20 (3x4mm)	38900B

\* For Tape & Reel, add suffix –Z (e.g. MP38900DL–Z)
For RoHS compliant packaging, add suffix –LF (e.g. MP38900DL–LF–Z)

\*\*\*For Tape & Reel, add suffix –Z (e.g. MP38900DL-B–Z)
For RoHS compliant packaging, add suffix –LF (e.g. MP38900DL-B–LF–Z)

## **PACKAGE REFERENCE**



# ABSOLUTE MAXIMUM RATINGS (1)

Supply Voltage V <sub>IN</sub> 18V	/
Supply Voltage V <sub>CC</sub> 6V	/
$V_{SW}$ 0.3V to $V_{IN}$ + 0.3V	
V <sub>BST</sub> V <sub>SW</sub> + 6V	
I <sub>VIN (RMS)</sub>	
V <sub>PGOOD</sub> 0.3V to V <sub>CC</sub> +0.6V	/
All Other Pins0.3V to +6V	
Continuous Power Dissipation $(T_A = +25^{\circ}C)^{(1)}$	2)
2.6V	N
Junction Temperature150°C	)
Lead Temperature260°C	
Storage Temperature65°C to +150°C	)
Recommended Operating Conditions (3)	
Supply Voltage V 45V to 16V	,

# 

Thermal Resistance	$^{(4)}$ $ heta$ JA	<b>0</b> JC
QFN20 (3x4mm)	48	10°C/W

#### Notes:

- 1) Exceeding these ratings may damage the device.
- 2) The maximum allowable power dissipation is a function of the maximum junction temperature T<sub>J</sub>(MAX), the junction-to-ambient thermal resistance θ<sub>JA</sub>, and the ambient temperature T<sub>A</sub>. The maximum allowable continuous power dissipation at any ambient temperature is calculated by P<sub>D</sub>(MAX)=(T<sub>J</sub>(MAX)-T<sub>A</sub>)/θ<sub>JA</sub>. Exceeding the maximum allowable power dissipation will cause excessive die temperature, and the regulator will go into thermal shutdown. Internal thermal shutdown circuitry protects the device from permanent damage.
- The device is not guaranteed to function outside of its operating conditions.
- 4) Measured on JESD51-7, 4-layer PCB.



# **ELECTRICAL CHARACTERISTICS**

 $V_{IN}$  = 12V,  $V_{CC}$ =5V,  $T_A$  = +25°C, unless otherwise noted.

Parameters	Symbol	Condition	Min	Тур	Max	Units
Input Supply Current (Shutdown)	I <sub>IN</sub>	V <sub>EN</sub> = 0V		0	1	μA
Input Supply Current (Quiescent)	I <sub>IN</sub>	V <sub>EN</sub> = 2V, V <sub>FB</sub> = 0.95V, MP38900-B <sup>(6)</sup>		420		μΑ
Input Supply Current (Quiescent)	I <sub>IN</sub>	V <sub>EN</sub> = 2V, V <sub>FB</sub> = 0.95V MP38900 <sup>(6)</sup>		40		μΑ
Vcc Supply Current (Quiescent)	lvcc	V <sub>EN</sub> = 2V, V <sub>FB</sub> = 1V MP38900		350		μΑ
HS Switch On Resistance (5)	HS <sub>RDS-ON</sub>			27		mΩ
LS Switch On Resistance (5)	LS <sub>RDS-ON</sub>			10		mΩ
Switch Leakage	SW <sub>LKG</sub>	V <sub>EN</sub> = 0V, V <sub>SW</sub> = 0V or 12V		0	1	μA
Current Limit	ILIMIT			16.5		Α
One-Shot On Time	T <sub>ON</sub>	R7=250kΩ, V <sub>OUT</sub> =1.05V		300		ns
Minimum Off Time <sup>(5)</sup>	T <sub>OFF</sub>			100		ns
Fold-back Off Time(5)	T <sub>FB</sub>	I <sub>LIM</sub> =1 (HIGH)		7.5		μs
OCP hold-off time <sup>(5)</sup>	Toc	I <sub>LIM</sub> =1 (HIGH)		50		μs
Feedback Voltage	$V_{FB}$		807	815	823	mV
Feedback Current	I <sub>FB</sub>	$V_{FB} = 815 \text{mV}$		10	50	nA
Soft Start Charging Current	+lss	Vss=0V		8.5		μA
Soft Stop Discharging Current	-I <sub>SS</sub>	V <sub>SS</sub> =0.815V		8.5		μA
Power Good Rising Threshold	PGOOD <sub>Vth</sub> -Hi			0.9		$V_{FB}$
Power Good Falling Threshold	PGOOD <sub>Vth</sub> -Lo			0.85		$V_{FB}$
Power Good Rising Delay	T <sub>PGOOD</sub>	Tss = 2ms, MP38900		1.5		ms
Power Good Rising Delay	T <sub>PGOOD</sub>	MP38900-B		1.5		ms
EN Rising Threshold	EN <sub>∨th-Hi</sub>		1.05	1.35	1.60	V
EN Threshold Hysteresis	EN <sub>∨th-Hys</sub>			420		mV
EN Input Current	I <sub>EN</sub>	V <sub>EN</sub> = 2V		1.5		μA
Vcc Under-Voltage Lockout Threshold Rising	VccUVvth	MP38900	3.8	4.0	4.2	V
Vcc Under-Voltage Lockout Threshold Hysteresis	VccUV <sub>HYS</sub>	MP38900		880		mV
VIN Under-Voltage Lockout Threshold Rising	VINUV <sub>Vth</sub>	MP38900-B	3.8	4.0	4.2	V
VIN Under-Voltage Lockout Threshold Hysteresis	VINUV <sub>HYS</sub>	MP38900-B		880		mV
V <sub>CC</sub> Regulator Output Voltage	Vcc	MP38900-B		5		V
Vcc Regulator Load Regulation		MP38900-B, Icc=5mA			5	%
Vout Over-Voltage Protection Threshold	Vove			1.25		V <sub>FB</sub>



# **ELECTRICAL CHARACTERISTICS** (continued)

 $V_{IN}$  = 12V,  $V_{CC}$ =5V,  $T_A$  = +25°C, unless otherwise noted.

Parameters	Symbol	Condition	Min	Тур	Max	Units
V <sub>OUT</sub> Under-Voltage Detection Threshold	$V_{UVP}$			0.7		$V_{FB}$
Thermal Shutdown	$T_{SD}$			150		°C
Thermal Shutdown Hysteresis	T <sub>SD-HYS</sub>			25		°C

#### Notes:

- 5) Guaranteed by design.6) If the test condition is marked with MP38900 or MP38900-B, the characteristic applies to MP38900 or MP38900-B respectively.



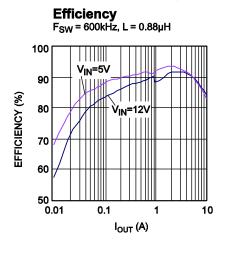
# **PIN FUNCTIONS**

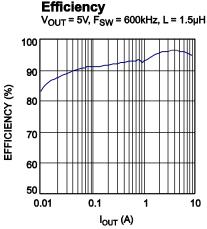
Pin #	Name	Description
1	AGND	Analog Ground.
2	FREQ	Frequency Set during CCM operation. The ON period is determined by the input voltage and the frequency-set resistor connected to FREQ pin. Connect a resistor to IN for line feed-forward. Decouple with a 1nF capacitor.
3	FB	Feedback. An external resistor divider from the output to GND, tapped to the FB pin, sets the output voltage.
4	SS	Soft Start. Connect an external SS capacitor to program the soft start time for the switch mode regulator. When the EN pin becomes high, an internal current source (8.5 $\mu$ A) charges up the SS capacitor and the SS voltage slowly ramps up from 0 to V <sub>FB</sub> smoothly. For MP38900, when the EN pin becomes low, an internal current source (8.5 $\mu$ A) discharges the SS capacitor and the SS voltage slowly ramps down. For MP38900-B, SS will pull low as soon as EN goes low.
5	EN	EN=1 to enable the MP38900/MP38900-B. For automatic start-up, connect EN pin to IN with a 100k $\Omega$ resistor. It includes an internal 1M $\Omega$ pull-down resistor.
6	PGOOD	Power Good Output. The output of this pin is an open drain and is high if the output voltage is higher than 90% of the nominal voltage. There is delay from FB $\geq$ 90% to PGOOD high, which is 50% of SS time plus 0.5ms. For MP38900-B, the delay is fixed as 1.5ms.
7	BST	Bootstrap. A capacitor connected between SW and BS pins is required to form a floating supply across the high-side switch driver.
8, 19	IN	Supply Voltage. The MP38900/MP38900-B operates from a +4.5V to +16V input rail. C1 is needed to decouple the input rail. Use wide PCB traces and multiple vias to make the connection.
9, 10, 17, 18	SW	Switch Output. Use wide PCB traces and multiple vias to make the connection.
11-16	PGND	System Ground. This pin is the reference ground of the regulated output voltage. For this reason care must be taken in PCB layout.
20	VCC	MP38900: External 5V Supply. This 5V supply has to be applied in order to bias the device. Decouple with a 1 $\mu$ F capacitor as close to this pin as possible. MP38900-B: Internal 5V supply. Decouple with a 1 $\mu$ F capacitor as close to this pin as possible.

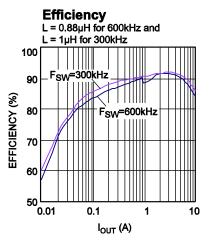


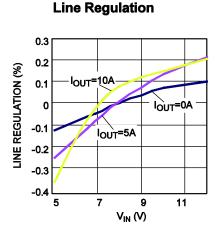
## TYPICAL PERFORMANCE CHARACTERISTICS

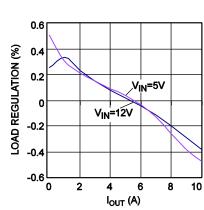
 $V_{IN}=12V$ ,  $V_{OUT}=1.2V$ , L=1.0 $\mu$ H,  $T_A=+25$ °C, unless otherwise noted.



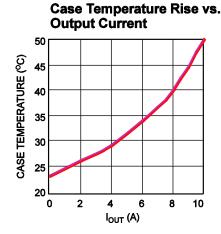


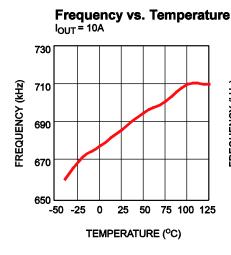


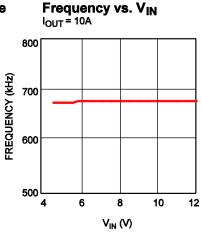


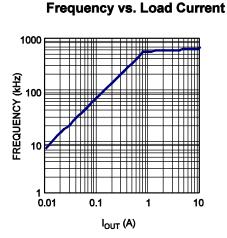


**Load Regulation** 



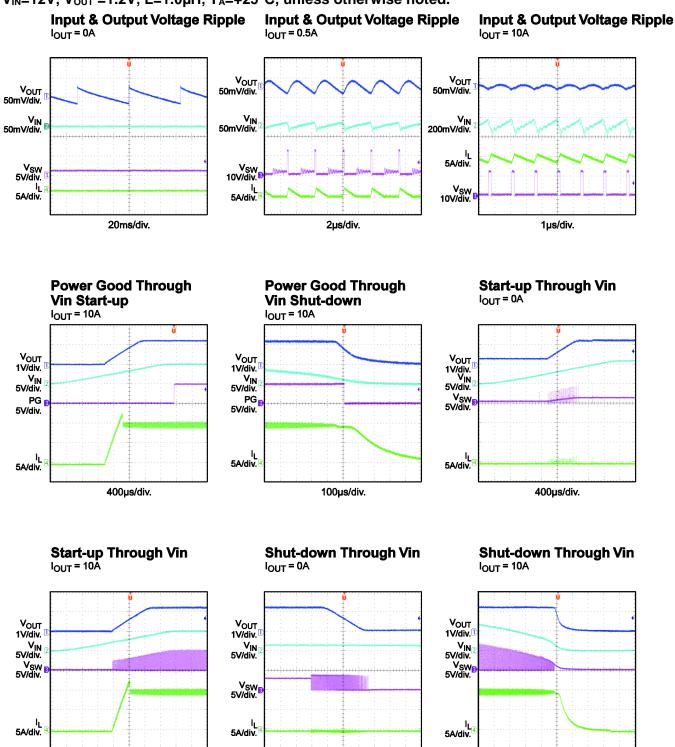






# TYPICAL PERFORMANCE CHARACTERISTICS (continued)

V<sub>IN</sub>=12V, V<sub>OUT</sub> =1.2V, L=1.0µH, T<sub>A</sub>=+25°C, unless otherwise noted.



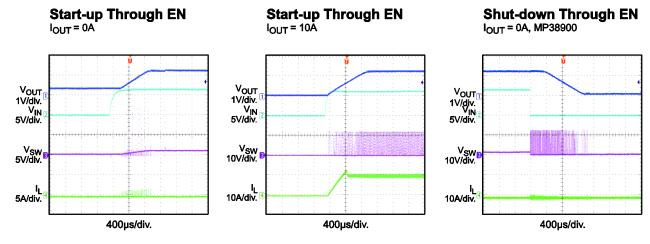
400µs/div.

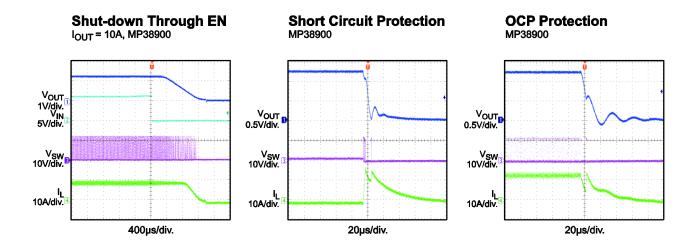
400µs/div.

400µs/div.

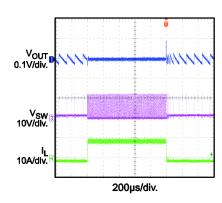
# TYPICAL PERFORMANCE CHARACTERISTICS (continued)

 $V_{IN}$ =12V,  $V_{OUT}$  =1.2V, L=1.0 $\mu$ H,  $T_A$ =+25°C, unless otherwise noted.

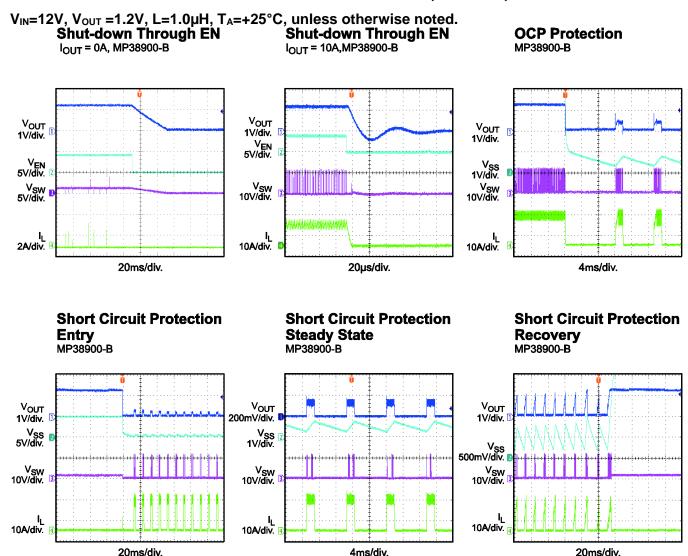




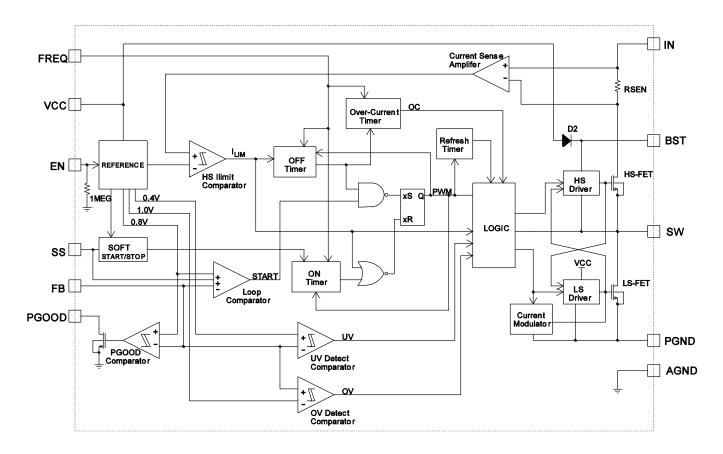
#### **Transient**



# TYPICAL PERFORMANCE CHARACTERISTICS (continued)



# **BLOCK DIAGRAM**



**Figure 2: Functional Block Diagram** 



#### **OPERATION**

#### **PWM Operation**

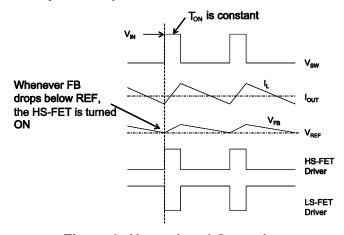
The MP38900/MP38900-B is a fully integrated synchronous rectified step-down switch mode converter. Constant-on-time (COT) control is employed to provide fast transient response and easy loop stabilization. At the beginning of each cycle, the high-side MOSFET (HS-FET) is turned on when the feedback voltage ( $V_{FB}$ ) is below the reference voltage ( $V_{REF}$ ) which indicates insufficient output voltage. The ON period is determined by the input voltage and the frequency-set resistor as follows:

$$t_{on}(ns) = \frac{12 \times R7(k\Omega)}{V_{IN}(V) - 0.45} + t_{DELAY1}(ns)$$
 (1)

Where R7 is the resistor to set switching frequency,  $t_{\text{DELAY1}}$  is the 20ns delay of a comparator in the  $t_{\text{ON}}$  module.

After the ON period elapses, the HS-FET is turned off, or becomes OFF state. It is turned ON again when V<sub>FB</sub> drops below V<sub>REF</sub>. By repeating operation this way, the converter regulates the output voltage. The integrated low-side MOSFET (LS-FET) is turned on when the HS-FET is in its OFF state to minimize the conduction loss. There will be a dead short between input and GND if both HS-FET and LS-FET are turned on at the same time. It's called shoot-through. In order to avoid shoot-through, a dead-time (DT) is internally generated between HS-FET off and LS-FET on, or LS-FET off and HS-FET on.

#### **Heavy-Load Operation**



**Figure 3: Heavy Load Operation** 

As Figure 3 shows, when the output current is high, the HS-FET and LS-FET repeat on/off as described above. In this operation, the inductor current will never go to zero. It's called continuous-conduction-mode (CCM) operation. In CCM operation, the switching frequency (f<sub>SW</sub>) is fairly constant.

## **Light-Load Operation**

When the load current decreases. The MP38900/MP38900-B reduces the switching frequency automatically to maintain efficiency. The light load operation is shown in Figure 4. The V<sub>FB</sub> does not reach V<sub>REF</sub> when the inductor current is approaching zero. As the current reduces from heavy-load condition, the inductor current also decreases, and eventually comes close to zero. The LS-FET driver turns into tri-state (high Z) whenever the inductor current reaches zero level. A current modulator takes over the control of LS-FET and limits the inductor current to less than 600µA. Hence, the output capacitors discharge slowly to GND through LS-FET as well as R1 and R2. As a result, the efficiency at light load condition is greatly improved. At light load condition, the HS-FET is not turned ON as frequently as at heavy load condition. This is called skip mode.

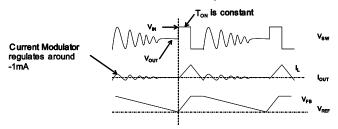


Figure 4: Light Load Operation

As the output current increases from the light load condition, the time period within which the current modulator regulates becomes shorter. The HS-FET is turned on more frequently. Hence, the switching frequency increases correspondingly. The output current reaches the critical level when the current modulator time is zero. The critical level of the output current is determined as follows:

$$I_{OUT} = \frac{(V_{IN} - V_{OUT}) \times V_{OUT}}{2 \times L \times F_{SW} \times V_{IN}}$$
 (2)

It turns into PWM mode once the output current exceeds the critical level. After that, the switching frequency stays fairly constant over the output current range.

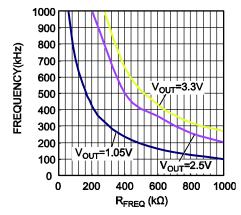
#### **Switching Frequency**

Constant-on-time (COT) control is used in the MP38900/MP38900-B and there is no dedicated oscillator in the IC. The input voltage is feedforwarded to the on-time one-shot timer through the resistor R7. The duty ratio is kept as  $V_{\text{OUT}}/V_{\text{IN}}$ . Hence, the switching frequency is fairly constant over the input voltage range. The switching frequency can be set as follows:

$$f_{SW}(kHz) = \frac{10^{6}}{\frac{12 \times R7(k\Omega)}{V_{IN}(V) - 0.45} \times \frac{V_{IN}(V)}{V_{OUT}(V)} + t_{DELAY2}(ns)}$$
(3)

Where  $t_{\text{DELAY2}}$  is the comparator delay. It's about 40ns.

#### Frequency vs. RFREQ



MP38900/MP38900-B is optimized to operate at high switching frequency with high efficiency. High switching frequency makes it possible to utilize small sized LC filter components to save system PCB space.

#### **Jitter and FB Ramp Slope**

Figure 5 and Figure 6 show jitter occurring in both PWM mode and skip mode. When there is noise in the  $V_{FB}$  downward slope, the ON time of the HS-FET driver deviates from its intended location and produces jitter. It is necessary to understand that there is a relationship between a system's stability and the steepness of the  $V_{FB}$  ripple's downward slope. The slope steepness of

the  $V_{FB}$  ripple dominates in noise immunity. The magnitude of the  $V_{FB}$  ripple doesn't affect the noise immunity directly.

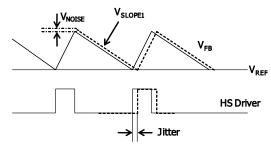


Figure 5: Jitter in PWM Mode

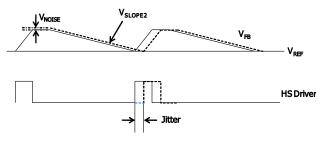


Figure 6: Jitter in Skip Mode

## Ramp with Large ESR Cap

In the case of POSCAP or other types of capacitor with larger ESR is applied as output capacitor. The ESR ripple dominates the output ripple, and the slope on the FB is quite ESR related. Figure 7 shows an equivalent circuit in PWM mode with the HS-FET off and without an external ramp circuit. Turn to application information section for design steps with large ESR caps.

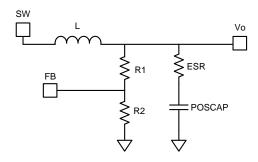


Figure 7: Simplified Circuit in PWM Mode without External Ramp Compensation

To realize the stability when no external ramp is used, usually the ESR value should be chosen as follow:

$$R_{\text{ESR}} \ge \frac{\frac{t_{\text{SW}}}{0.7 \times \pi} + \frac{t_{\text{ON}}}{2}}{C_{\text{OUT}}} \tag{4}$$

tsw is the switching period.

When using a large-ESR capacitor on the output, add a ceramic capacitor with a value of 10uF or less to in parallel to minimize the effect of ESL.

## Ramp with Small ESR Cap

When the output capacitors are ceramic ones, the ESR ripple is not high enough to stabilize the system, and external ramp compensation is needed. Skip to application information section for design steps with small ESR caps.

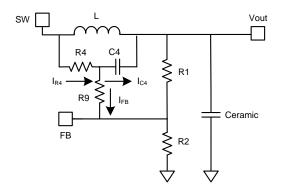


Figure 8: Simplified Circuit in PWM Mode with External Ramp Compensation

Figure 8 shows a simplified external ramp compensation (R4 and C4) for PWM mode, with HS-FET off. Chose R1, R2, R9 and C4 of the external ramp to meet the following condition:

$$\frac{1}{2\pi \times \mathsf{F}_{\mathsf{SW}} \times \mathsf{C}_{\mathsf{4}}} < \frac{1}{5} \times \left( \frac{\mathsf{R}_{\mathsf{1}} \times \mathsf{R}_{\mathsf{2}}}{\mathsf{R}_{\mathsf{1}} + \mathsf{R}_{\mathsf{2}}} + \mathsf{R}_{\mathsf{9}} \right) \tag{5}$$

Where:

$$I_{R4} = I_{C4} + I_{FB} \approx I_{C4}$$
 (6)

And the Vramp on the  $V_{FB}$  can then be estimated as:

$$V_{RAMP} = \frac{V_{IN} - V_{OUT}}{R_4 \times C_4} \times t_{ON} \times \frac{R_1 // R_2}{R_1 // R_2 + R_9}$$
 (7)

The downward slope of the  $V_{\text{FB}}$  ripple then follows

$$V_{SLOPE1} = \frac{-V_{RAMP}}{t_{off}} = \frac{-V_{OUT}}{R_4 \times C_4}$$
 (8)

As can be seen from equation 8, if there is instability in PWM mode, we can reduce either R4 or C4. If C4 can not be reduced further due to limitation from equation 5, then we can only reduce R4. For a stable PWM operation, the  $V_{slope1}$  should be design follow equation 9.

$$-V_{\text{slope1}} \ge \frac{\frac{t_{\text{SW}}}{0.7 \times \pi} + \frac{t_{\text{ON}}}{2} - R_{\text{ESR}} C_{\text{OUT}}}{2 \times L \times C_{\text{OUT}}} V_{\text{OUT}} + \frac{Io \times 10^{-3}}{t_{\text{SW}} - t_{\text{on}}}$$
(9)

Where Io is the load current.

In skip mode, the downward slope of the  $V_{FB}$  ripple is the same whether the external ramp is used or not. Figure 9 shows the simplified circuit of the skip mode when both the HS-FET and LS-FET are off.

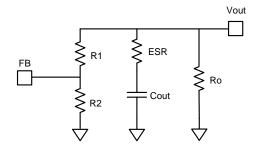


Figure 9: Simplified Circuit in skip Mode

The downward slope of the V<sub>FB</sub> ripple in skip mode can be determined as follow:

$$V_{SLOPE2} = \frac{-V_{REF}}{((R_1 + R_2) // Ro) \times C_{OUT}}$$
 (10)

Where Ro is the equivalent load resistor.

As described in Figure 6, V<sub>SLOPE2</sub> in the skip mode is lower than that is in the PWM mode, so it is reasonable that the jitter in the skip mode is larger. If one wants a system with less jitter during ultra light load condition, the values of the V<sub>FB</sub> resistors should not be too big, however, that will decrease the light load efficiency.

## **Bootstrap Charging**

The floating power MOSFET driver is powered by an external  $V_{CC}$  through D2 as shown in Figure 2. This floating driver has its own UVLO protection. This UVLO's rising threshold is 2.2V with a hysteresis of 150mV. The recommended BST cap C4 is  $1\mu F$ .

#### Soft Start/Stop

The MP38900 employ soft start/stop (SS) mechanism to ensure smooth output during power-up and power shutdown. When the EN pin becomes high, an internal current source (8.5 $\mu$ A) charges up the SS CAP. The SS CAP voltage takes over the V<sub>REF</sub> voltage to the PWM comparator. The output voltage smoothly ramps up with the SS voltage. Once the SS voltage reaches the same level as the REF voltage, it keeps ramping up while REF takes over the PWM comparator. At this point, the soft start finishes and it enters into steady state operation.

When the EN pin becomes low, the SS CAP voltage is discharged through an 8.5µA internal current source. Once the SS voltage reaches REF voltage, it takes over the PWM comparator. The output voltage will decrease smoothly with SS voltage until zero level. The SS CAP value can be determined as follows:

$$C_{SS}(nF) = \frac{t_{SS}(ms) \times I_{SS}(\mu A)}{V_{RFF}(V)}$$
 (11)

If the output capacitors have large capacitance value, it's not recommended to set the SS time too small. A minimal value of 4.7nF should be used if the output capacitance value is larger than  $330\mu F$ .

MP38900-B has the same soft start mechanism, however, the soft shut-down feature is disabled to support output prebias applications.

#### **Power Good (PGOOD)**

The MP38900/MP38900-B has power-good (PGOOD) output. The PGOOD pin is the open drain of a MOSFET. It should be connected to  $V_{\rm CC}$  or other voltage source through a resistor (e.g. 100k). After the input voltage is applied, the MOSFET is turned on, so that the PGOOD pin is pulled to GND before SS ready. After FB voltage reaches 90% of REF voltage, the PGOOD pin is pulled high after a delay.

The PGOOD delay time is determined as follows: MP38900:

$$t_{PGOOD}(ms) = 0.5 \times t_{SS}(ms) + 0.5$$

MP38900-B:

$$t_{PGOOD} (ms) = 1.5ms \tag{12}$$

When the FB voltage drops to 85% of the REF voltage, the PGOOD pin will be pulled low.

# Over-Current Protection (OCP) and Short-Circuit Protection (SCP)

The MP38900/MP38900-B has cycle-by-cycle over-current limit control. The inductor current is monitored during the ON state. Once it detects that the inductor current is higher than the current limit, the HS-FET is turned off. At the same time, the OCP timer is started. The OCP timer is set as 40µs. If in the following 40µs, the current limit is hit for every cycle, then it'll trigger OCP.

When the current limit is hit and the FB voltage is lower than 50% of the REF voltage, the device considers this as a dead short on the output and triggers OCP immediately. This is short circuit protection (SCP).

Under OCP/SCP condition, MP38900 will latch off. The converter needs power cycle to restart. MP38900-B will enter hiccup mode, and restart by itself once the OCP/SCP condition is removed.

#### Over/Under-voltage Protection (OVP/UVP)

The MP38900/MP38900-B monitors the output voltage through a resistor divider feedback (FB) voltage to detect overvoltage and undervoltage on the output. When the FB voltage is higher than 125% of the REF voltage, it'll trigger OVP. Once it triggers OVP, the LS-FET is always on while the HS-FET is always off. It needs power cycle to power up again. When the FB voltage is below 70% of the REF voltage (0.815V), UVP will be triggered. Usually, UVP accompanies a hit in current limit and this results in SCP.

#### **UVLO** protection

The MP38900/MP38900-B has under-voltage lock-out protection (UVLO). When  $V_{\text{CC}}$  is higher than the UVLO rising threshold voltage, the MP38900/MP38900-B will be powered up. It shuts off when  $V_{\text{CC}}$  is lower than the UVLO falling threshold voltage. This is non-latch protection.



## **Thermal Shutdown**

Thermal shutdown is employed in the MP38900/MP38900-B. The junction temperature of the IC is internally monitored. If the junction temperature exceeds the threshold value (typically 150°C), the converter shuts off. This is non-latch protection. There is about 25°C hysteresis. Once the junction temperature drops to around 125°C, it initiates a soft start.

## **APPLICATION INFORMATION**

#### **Setting the Output Voltage-Large ESR Caps**

For applications that electrolytic capacitor or POS capacitor with a controlled output of ESR is set as output capacitors. The output voltage is set by feedback resistors R1 and R2. As Figure 10 shows.

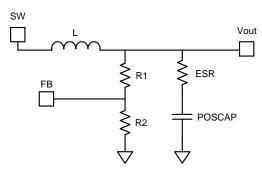


Figure 10: Simplified Circuit of POS Capacitor

First, choose a value for R2. R2 should be chosen reasonably, a small R2 will lead to considerable quiescent current loss while too large R2 makes the FB noise sensitive. It is recommended to choose a value within  $5k\Omega$ -  $50k\Omega$  for R2, using a comparatively larger R2 when Vout is low, etc.,1.05V, and a smaller R2 when Vout is high. Then R1 is determined as follow with the output ripple considered:

$$R_1 = \frac{V_{OUT} - \frac{1}{2}\Delta V_{OUT} - V_{REF}}{V_{REF}} \cdot R_2$$
 (13)

 $\Delta V_{\text{OUT}}$  is the output ripple determined by equation 21.

#### Setting the Output Voltage-Small ESR Caps

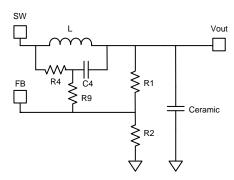


Figure 11: Simplified Circuit of Ceramic Capacitor

When low ESR ceramic capacitor is used in the output, an external voltage ramp should be added to FB through resistor R4 and capacitor

C4. The output voltage is influenced by ramp voltage  $V_{RAMP}$  besides R divider as shown in Figure 11. The  $V_{RAMP}$  can be calculated as shown in equation 7. R2 should be chosen reasonably, a small R2 will lead to considerable quiescent current loss while too large R2 makes the FB noise sensitive. It is recommended to choose a value within  $5k\Omega$ - $50k\Omega$  for R2, using a comparatively larger R2 when Vo is low, etc.,1.05V, and a smaller R2 when Vo is high. And the value of R1 then is determined as follow:

$$R_{1} = \frac{R_{2}}{V_{FB(AVG)}} - \frac{R_{2}}{R_{4} + R_{9}}$$
 (14)

The  $V_{FB(AVG)}$  is the average value on the FB,  $V_{FB(AVG)}$  varies with the Vin, Vo, and load condition, etc., its value on the skip mode would be lower than that of the PWM mode, which means the load regulation is strictly related to the  $V_{FB(AVG)}$ . Also the line regulation is related to the  $V_{FB(AVG)}$ . If one wants to gets a better load or line regulation, a lower Vramp is suggested, as long as the criterion shown in equation 8 can be met.

For PWM operation,  $V_{\text{FB}(AVG)}$  value can be deduced from the equation below.

$$V_{FB(AVG)} = V_{REF} + \frac{1}{2}V_{RAMP} \times \frac{R_1/\!\!/ R_2}{R_1/\!\!/ R_2 + R_9}$$
 (15)

Usually, R9 is set to  $0\Omega$ , and it can also be set following equation 16 for a better noise immunity. It should also set to be 5 timers smaller than R1//R2 to minimize its influence on Vramp.

$$R_9 = \frac{1}{2\pi \times C_4 \times 2F_{SW}} \tag{16}$$

Using equation 14 to calculate the R1 can be complicated. To simplify the calculation, a DC-blocking capacitor Cdc can be added to filter the DC influence from R4 and R9. Figure 12 shows a simplified circuit with external ramp compensation and a DC-blocking capacitor. With this capacitor, R1 can easily be obtained by using the simplified equation for PWM mode operation:

$$R_{1} = \frac{(V_{OUT} - V_{REF} - \frac{1}{2}V_{RAMP})}{V_{REF} + \frac{1}{2}V_{RAMP}}R_{2}$$
 (17)

Cdc is suggested to be at least 10 times larger than C4 for better DC blocking performance, and

should also not larger than 0.47uF considering start up performance. In case one wants to use larger Cdc for a better FB noise immunity, combined with reduced R1 and R2 to limit the Cdc in a reasonable value without affecting the system start up. Be noted that even when the Cdc is applied, the load and line regulation are still Vramp related.

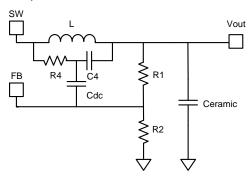


Figure 12: Simplified Circuit of Ceramic Capacitor with DC blocking capacitor

#### **Input Capacitor**

The input current to the step-down converter is discontinuous. Therefore, a capacitor is required to supply the AC current to the step-down converter while maintaining the DC input voltage. Ceramic capacitors are recommended for best performance. In the layout, it's recommended to put the input capacitors as close to the IN pin as possible.

The capacitance varies significantly temperature. Capacitors with X5R and X7R ceramic dielectrics are recommended because they are fairly stable over temperature.

The capacitors must also have a ripple current rating greater than the maximum input ripple current of the converter. The input ripple current can be estimated as follows:

$$I_{CIN} = I_{OUT} \times \sqrt{\frac{V_{OUT}}{V_{IN}}} \times (1 - \frac{V_{OUT}}{V_{IN}})$$
 (18)

The worst-case condition occurs at:

$$I_{CIN} = \frac{I_{OUT}}{2} \tag{19}$$

For simplification, choose the input capacitor whose RMS current rating is greater than half of the maximum load current.

The input capacitance value determines the input voltage ripple of the converter. If there is input voltage ripple requirement in the system design, choose the input capacitor that meets the specification.

The input voltage ripple can be estimated as follows:

$$\Delta V_{IN} = \frac{I_{OUT}}{F_{SW} \times C_{IN}} \times \frac{V_{OUT}}{V_{IN}} \times (1 - \frac{V_{OUT}}{V_{IN}})$$
 (20)

The worst-case condition occurs at  $V_{IN} = 2V_{OUT}$ , where:

$$\Delta V_{IN} = \frac{1}{4} \times \frac{I_{OUT}}{F_{SW} \times C_{IN}}$$
 (21)

#### **Output Capacitor**

The output capacitor is required to maintain the DC output voltage. Ceramic or POSCAP capacitors are recommended. The output voltage ripple can be estimated as:

$$\Delta V_{\text{OUT}} = \frac{V_{\text{OUT}}}{F_{\text{SW}} \times L} \times \left(1 - \frac{V_{\text{OUT}}}{V_{\text{IN}}}\right) \times \left(R_{\text{ESR}} + \frac{1}{8 \times F_{\text{SW}} \times C_{\text{OUT}}}\right) \tag{22}$$

Where R<sub>ESR</sub> is the equivalent series resistance (ESR) of the output capacitor.

In the case of ceramic capacitors, the impedance at the switching frequency is dominated by the capacitance. The output voltage ripple is mainly caused by the capacitance. For simplification, the output voltage ripple can be estimated as:

$$\Delta V_{\text{OUT}} = \frac{V_{\text{OUT}}}{8 \times F_{\text{SW}}^2 \times L \times C_{\text{OUT}}} \times (1 - \frac{V_{\text{OUT}}}{V_{\text{IN}}})$$
 (23)

The output voltage ripple caused by ESR is very small. Therefore, an external ramp is needed to stabilize the system. The external ramp can be generated through resistor R4 and capacitor C4 using the following equation 5, 8 and 9.

In the case of POSCAP capacitors, the ESR dominates the impedance at the switching frequency. The ramp voltage generated from the ESR is high enough to stabilize the system. Therefore, an external ramp is not needed. A minimum ESR value of  $12m\Omega$  is required to ensure stable operation of the converter. For simplification, the output ripple approximated as:

$$\Delta V_{OUT} = \frac{V_{OUT}}{F_{SW} \times L} \times (1 - \frac{V_{OUT}}{V_{IN}}) \times R_{ESR}$$
 (24)



#### Inductor

The inductor is required to supply constant current to the output load while being driven by the switching input voltage. A larger value inductor will result in less ripple current that will result in lower output ripple voltage. However, a larger value inductor will have a larger physical size, higher series resistance, and/or lower saturation current. A good rule for determining the inductor value is to allow the peak-to-peak ripple current in the inductor to be approximately 30~40% of the maximum switch current limit. Also, make sure that the peak inductor current is below the maximum switch current limit. The inductance value can be calculated as:

$$L = \frac{V_{OUT}}{F_{SW} \times \Delta I_L} \times (1 - \frac{V_{OUT}}{V_{IN}})$$
 (25)

Where  $\Delta I_{L}$  is the peak-to-peak inductor ripple current.

Choose an inductor that will not saturate under the maximum inductor peak current. The peak inductor current can be calculated as:

$$I_{LP} = I_{OUT} + \frac{V_{OUT}}{2F_{SW} \times L} \times (1 - \frac{V_{OUT}}{V_{IN}})$$
 (26)

The inductors listed in Table 1 are highly recommended for the high efficiency they can provide.

**Table 1: Inductor Selection Guide** 

Part Number	Manufacturer	Inductance (µH)	DCR (mΩ)	Current Rating (A)	Dimensions L x W x H (mm³)	Switching Frequency (kHz)
PCMC-135T-R68MF	Cyntec	0.68	1.7	34	13.5 x 12.6 x 4.8	600
FDA1254-1R0M	токо	1	2	25.2	13.5 x 12.6 x 5.4	300~600
FDA1254-1R2M	токо	1.2	2.05	20.2	13.5 x 12.6 x 5.4	300~600



## **Typical Design Parameter Tables**

The following tables include recommended component values for typical output voltages (1.05V, 1.2V, 1.8V, 2.5V, 3.3V) and switching frequencies (300kHz, and 600kHz). Tables 2-3 for design cases without external ramp compensation and Tables 4-5 for design cases with external ramp compensation. External ramp is not needed when high-ESR capacitors, such as electrolytic or POSCAPs are used. External ramp is needed when low-ESR capacitors, such as ceramic capacitors are used. For cases not listed in this datasheet, a calculator in excel spreadsheet can also be requested through a local sales representative to assist with the calculation.

Table 2: 300kHz,  $12V_{IN}$ , w/o External Ramp,  $C_{OUT}=220\mu F$ ,  $15m\Omega$ 

V <sub>оит</sub> (V)	L (µH)	R1 (kΩ)	R2 (kΩ)	R7 (kΩ)
1.05	1	5.49	20	324
1.2	1	9.1	20	357
1.8	2.0	12	10	475
2.5	2.0	20.5	10	680
3.3	2.0	30.1	10	866

Table 3: 600kHz,  $12V_{IN}$ , w/o External Ramp, C<sub>OUT</sub> =220μF, 15mΩ

V <sub>оит</sub> (V)	L (μΗ)	R1 (kΩ)	R2 (kΩ)	R7 (kΩ)
1.05	0.68	5.6	20	147
1.2	0.68	9.1	20	165
1.8	1.2	12.1	10	240
2.5	1.2	21	10	330
3.3	1.2	30.9	10	442

Table 4: 300kHz, 12V<sub>IN</sub>, with External Ramp

V <sub>OUT</sub> (V)	L (µH)	R1 (kΩ)	R2 (kΩ)	R4 (kΩ)	C4 (pF)	R7 (kΩ)
1.05	1	5.11	20	300	220	324
1.2	1	8.87	20	300	220	357
1.8	2.0	12	10	590	220	475
2.5	2.0	20.5	10	590	220	680
3.3	2.0	30.9	10	590	220	866

Table 5: 600kHz, 12V<sub>IN</sub>, with External Ramp

V <sub>OUT</sub> (V)	L (µH)	R1 (kΩ)	R2 (kΩ)	R4 (kΩ)	C4 (pF)	R7 (kΩ)
1.05	0.68	5.6	20	205	180	154
1.2	0.68	9.1	20	205	180	169
1.8	1.2	12.1	10	300	180	240
2.5	1.2	21.5	10	300	180	330
3.3	1.2	33	10	300	180	453



# **TYPICAL APPLICATION**

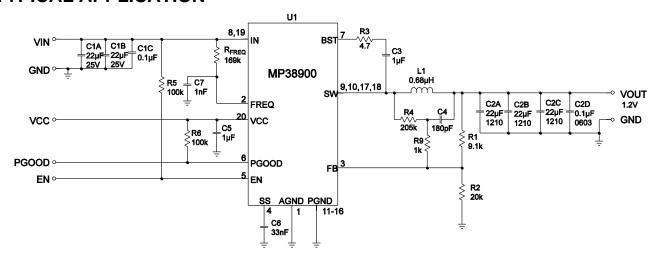


Figure 13: Typical Application Circuit with Low ESR Ceramic Capacitor

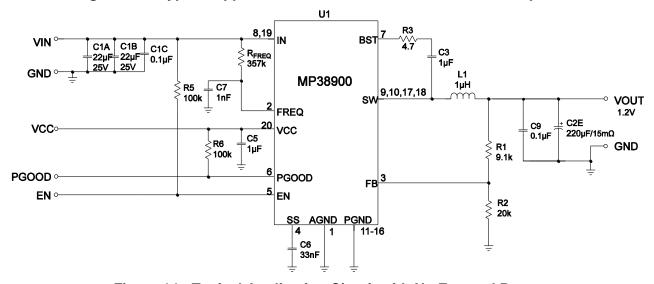
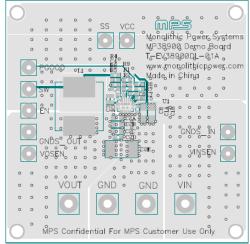


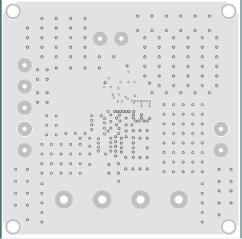
Figure 14: Typical Application Circuit with No External Ramp

## LAYOUT RECOMMENDATION

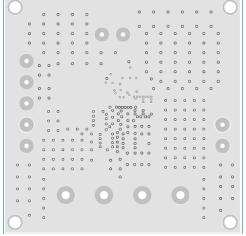
- 1. The high current paths (GND, IN, and SW) should be placed very close to the device with short, direct and wide traces.
- 2. Put the input capacitors as close to the IN and GND pins as possible.(<2mm)
- 3. Put the decoupling capacitor as close to the  $V_{\text{CC}}$  and GND pins as possible.
- 4. Keep the switching node SW short and away from the feedback network.
- 5. The external feedback resistors should be placed next to the FB pin. Make sure that there is no via on the FB trace.
- 6. Keep the BST voltage path (BST, C<sub>BST</sub>, and SW) as short as possible.
- 7. Keep the bottom IN and SW pads connected with large copper to achieve better thermal performance.
- 8. Four-layer layout is strongly recommended to achieve better thermal performance.



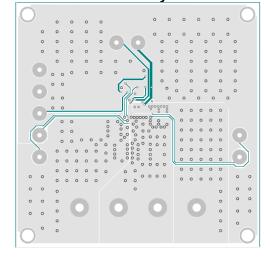
**Top Layer** 



Inner1 Layer



**Inner2 Layer** 



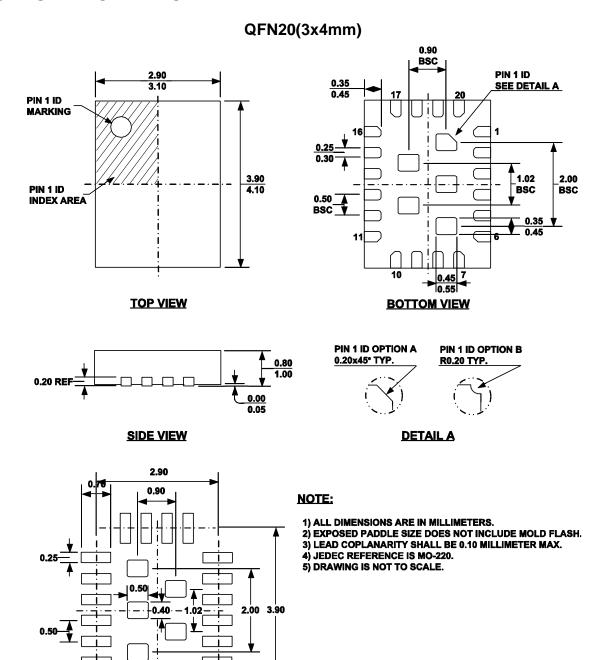
**Bottom Layer** 

Figure 15: PCB Layout

© 2021 MPS. All Rights Reserved.



## **PACKAGE INFORMATION**



**NOTICE:** The information in this document is subject to change without notice. Users should warrant and guarantee that third party Intellectual Property rights are not infringed upon when integrating MPS products into any application. MPS will not assume any legal responsibility for any said applications.

**RECOMMENDED LAND PATTERN**